LISTING OF AND AMENDMENTS TO CLAIMS:

1. - 11. (canceled)

- 12. (currently amended) An apparatus for filing vias in a wafer, comprising:
- a chamber in which to place the wafer, said chamber being capable of being evacuated;
 - a surface upon which to place said wafer;
- a <u>pressurized</u> paste delivery portion for providing a paste to fill said vias; and
- a <u>pressurized</u> paste filling portion for bringing said paste into contact with said vias under pressure so that said paste fills said vias.
- 13. (currently amended) The apparatus as recited in claim 12, wherein said paste filling portion provides said paste at a pressure within [[with]] the range of 10 to 100 PSI.
- 14. (currently amended) The apparatus as recited in claim 12, wherein said paste <u>filling delivery</u> portion comprises:
 - a planar surface onto which said paste is deposited; and
- a mechanism for applying pressure so that said paste on said surface is forced into contact with said wafer.
- 15. (original) The apparatus as recited in claim 14, wherein said paste delivery portion comprises:
 - a surface onto which said paste is deposited; and
- a passageway through which said paste is delivered to said surface.

- 16. (original) The apparatus as recited in claim 14, wherein said mechanism for applying pressure comprises:
 - a plate which defines said surface; and

components for applying a pressure differential to said plate so as to force said plate toward said wafer.

- 17. (original) The apparatus as recited in claim 16, further comprising a compliant material on said surface to which said paste is applied.
- 18. (withdrawn) The apparatus as recited in claim 12, wherein said paste filling portion comprises:
 - a plate having a portion for receiving said paste;
- a first seal for sealing said plate to said surface upon which said wafer is placed;
- a second seal for sealing said paste between said plate and said plate and said wafer; and
- a mechanism for forcing said plate towards said wafer so that said paste is forced into said vias of said wafer.
- 19. (withdrawn) The apparatus as recited in claim 18, wherein said mechanism for forcing said plate towards said wafer comprises:
- gas removal apparatus for evacuating gas between said plate and said surface upon which said wafer is placed; and
- gas replacement apparatus for replacing gas evacuated from said chamber.
- 20. (withdrawn) The apparatus as recited in claim 19, wherein said gas replacement apparatus comprises an opening through which gas is permitted to enter said chamber.

- 21. (original) The apparatus as recited in claim 12, wherein said surface upon which to place said wafer comprises a base plate having a recess for said wafer.
- 22. (original) The apparatus as recited in claim 21, wherein said surface upon which to place said wafer comprises a surface of an electrostatic chuck.
- 23. (original) The apparatus as recited in claim 12, wherein said paste delivery portion comprises a pressurized paste reservoir.
- 24. (withdrawn) The apparatus as recited in claim 12, wherein said paste filling portion comprises:
- a piston housing having an opening for receiving a piston;
- a compliant seal for sealing said piston housing to a portion of said wafer so as to confine said paste;
 - a piston disposed in said piston housing; and
- a piston actuator for forcing said piston toward said wafer;

wherein said paste delivery portion provides said paste to said opening.

- 25. (withdrawn) The apparatus as recited in claim 24, further comprising:
- a mechanism for moving said piston housing so that said seal is compressed for filing said vias.
- 26. (withdrawn) The apparatus as recited in claim 25, wherein

said mechanism for moving said piston housing further moves said piston housing to a position wherein said seal is compressed to a lesser degree than when said vias are filled, to thereby allow said piston housing to be moved so that said piston housing is disposed so as to be in a position to fill vias of one or more successive portions of said wafer with paste delivered to said opening.

- 27. (withdrawn) The apparatus as recited in claim 24, further comprising a mechanism for cleaning said piston of excess paste after vias of a wafer have been filled.
- 28. (original) The apparatus as recited in claim 12, wherein said paste filling portion comprises:

an elongate member having a surface with a slot through which paste is provided to said wafer; and

a compliant seal for sealing said surface to said wafer.

- 29. (original) The apparatus as recited in claim 28, further comprising a mechanism for translating said member and said wafer with respect to one another so as to fill vias in successive portions of said wafer.
- 30. (original) The apparatus as recited in claim 28, further comprising a mechanism for rotating said member and said wafer with respect to one another so as to fill vias in successive portions of said wafer.
- 31. (original) The apparatus as recited in claim 30, wherein said mechanism for rotating said member and said wafer with respect to one another comprising a rotating base having said

surface upon which said wafer is placed.

- 32. (original) The apparatus as recited in claim 28, configured to accept a circular wafer, wherein said elongate member is disposed radially with respect to said wafer.
- 33. (currently amended) The apparatus as recited in claim 32, wherein said elongate member has a length less than that of a radius of said wafer, wherein said apparatus further comprises:
 - a mechanism for rotating said wafer; and
- a mechanism for radially translating said member in a radial direction with respect to said wafer.
- 34. (original) The apparatus as recited in claim 33, wherein said mechanism for rotating said wafer includes a rotation speed control to control speed of rotation of said wafer.
- 35. (original) The apparatus as recited in claim 33, wherein said mechanism for radially translating said member includes a translation speed control to control speed of translation of said member with respect to said wafer.
- 36. (original) The apparatus as recited in claim 33, wherein said mechanism for radially translating said member includes a worm gear assembly, and a motor for rotating a drive shaft of said assembly.
- 37. (new) The apparatus as recited in claim 12, wherein said wafer is disposed entirely within said chamber.

- 38. (new) The apparatus as recited in claim 12, wherein said paste filling portion is disposed entirely within said chamber.
- 39. (new) The apparatus as recited in claim 12, wherein said wafer and said paste filling portion are disposed entirely within said chamber.